


<b>Search Notes</b>  	<b>Application/Control No.</b>  10527714	<b>Applicant(s)/Patent Under Reexamination</b>  GIERSCHIK ET AL.
	<b>Examiner</b>  Takele, Meseker	<b>Art Unit</b>  2174

SEARCHED			
Class	Subclass	Date	Examiner
715	822, 738, 736	1/7/2008	MT

SEARCH NOTES		
Search Notes	Date	Examiner
East search (US-PGPUB, ASPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM-TDB)	1/7/2008	MT
Inventor search	1/7/2008	MT
Discussed with Tadesse Hailu	07/03/2007	MT
Npl and google search	1/7/2008	MT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner